

# Some remarks on the removal of adhering particles by oscillating air flows

Uwe Schloßer, Thomas Bahners and Eckhard Schollmeyer

*Deutsches Textilforschungszentrum Nord-West e. V., Krefeld, Germany*



## Particle adhesion – I. van der Waals interaction

$F_{vdW}$  is caused by the interaction of atomic or molecular dipoles. According to the ‚macroscopic theory‘ by Krupp, the force between two planar surfaces is given by

$$F_{vdW} = \frac{h\varpi}{8 \cdot \pi^2 \cdot z_0^3}$$

where  $h\varpi$  is the Lifshitz-van der Waals constant ( $0.6 \text{ eV} = 9.6 \cdot 10^{-20} \text{ J}$ ) and  $z_0$  the closest distance between the surfaces (0.4 nm).

The more realistic (but still idealized) situation of a sphere of diameter  $2 \cdot R$  on a plane is described by

$$F_{vdW} = \frac{h\varpi}{8 \cdot \pi^2 \cdot z_0^2} \cdot R$$



## Particle adhesion – II. Electrostatic forces

Electrostatic forces are caused by excess charges on the particle surface. The force between a sphere and a plane is given by

$$F_{el} = \frac{q^2}{16 \cdot \pi \cdot \epsilon_0 \cdot R \cdot \delta} \cdot \frac{\ln\left(1 + \frac{\delta}{z_0}\right)}{\left(\gamma + \frac{1}{2} \ln\left(\frac{2 \cdot R}{z_0}\right)\right) \cdot \left(\gamma + \frac{1}{2} \ln\left(\frac{2 \cdot R}{z_0 + \delta}\right)\right)}$$

with

- $q$ : 'seen' charge of the particle, typically 20 to 30 % of the total charge  $Q$
- $\delta$ : thickness of the charged surface layer ( $q(\delta) = q_{\text{surface}} \cdot 1/e$ )
- $\epsilon_0$ : dielectric constant ( $8.86 \cdot 10^{-14}$  As/V cm)
- $\gamma$ : Euler's constant (0.5772)



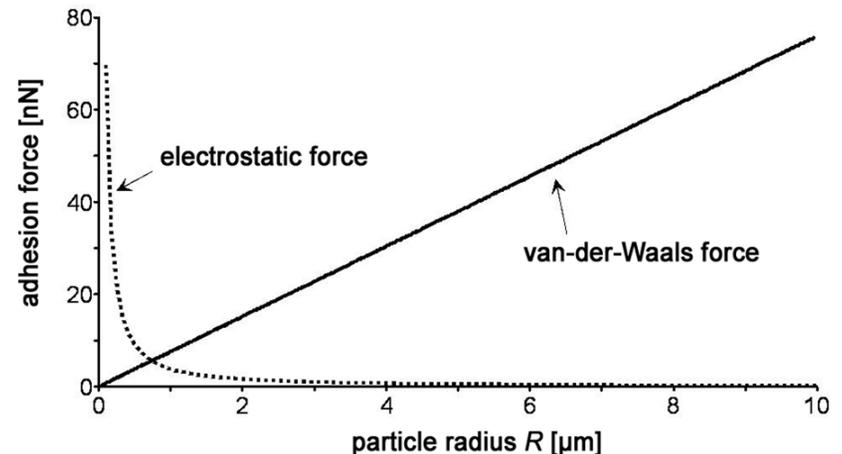
## Particle adhesion – II. Electrostatic forces

Quartz particles of 5 to 10  $\mu\text{m}$  diameter were found to have total charges of 500 to 1000 elementary charges.

Experimental studies using polymer particles with sizes ranging from 5 to 30  $\mu\text{m}$  by Kottler et al. showed that the measured  $F_{el}$  could be described the stated formula, if the total charge  $Q$  was greater than  $10^4 q_0$  ( $q_0 =$  elementary charge).

$F_{el}$  was equivalent to  $F_{vdw}$  if the total charge  $Q$  was smaller than  $10^4 q_0$ .

In the case of  $R > 5 \mu\text{m}$ ,  $F_{el}$  was 100 times smaller than  $F_{vdw}$ .



W. R. Harper, *Advances in Physics* **6**, 365 (1957)

L. B. Loeb, *Static Electrification*, Springer, 1959

W. Kottler, H. Krupp und H. Rabenhorst, *Z. angew. Physik* **24**, 219 (1968)

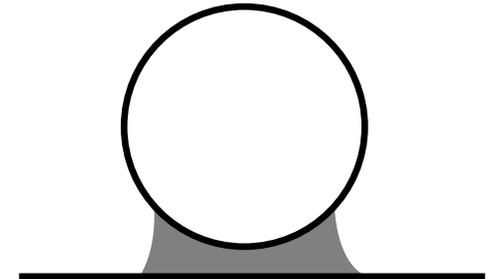
H. Rumpf, *Particle Adhesion, Proc. Agglomeration 77*, 2nd Symp. on Agglomeration, Atlanta 1977



## Particle adhesion – III. Capillary forces

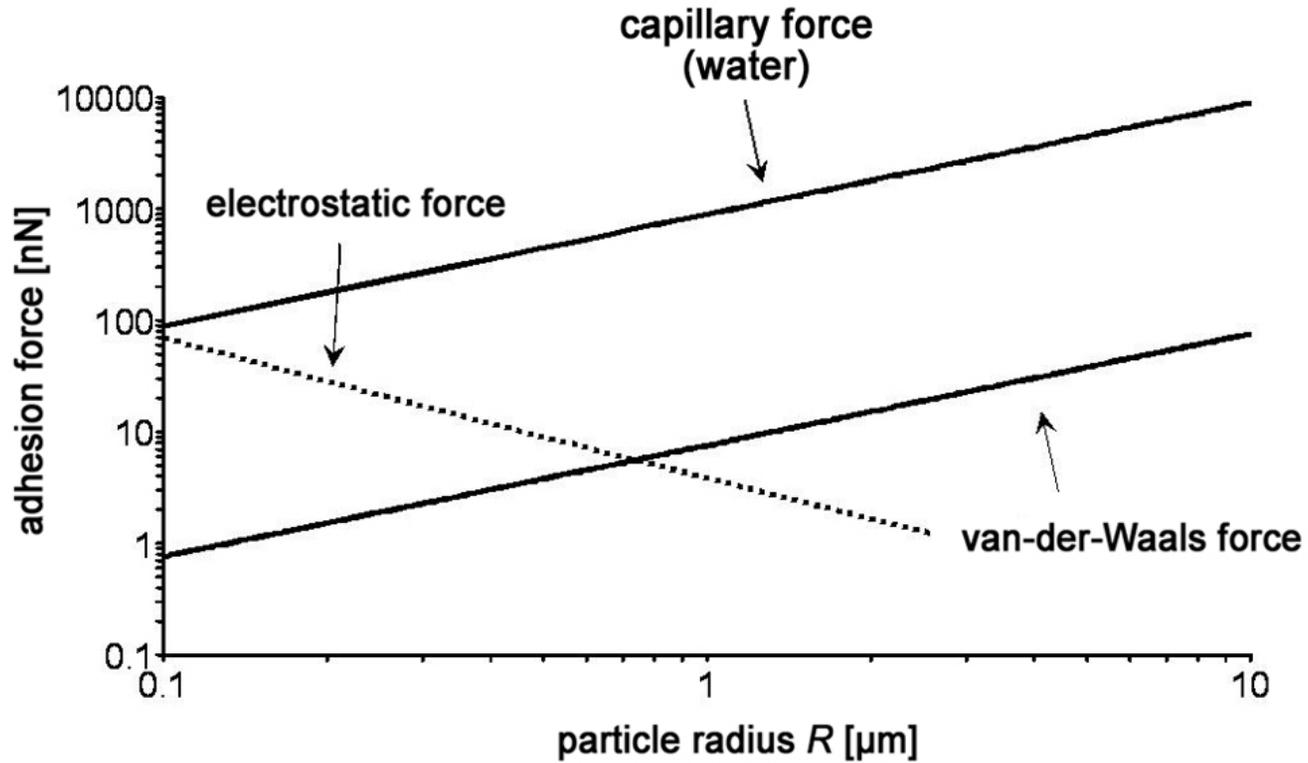
Capillary forces are caused by liquid between particle and surface. Assuming idealized geometry – spherical particle and plane – the capillary force is given by  
between a sphere and a plane is given by

$$F_{cap} = 4\pi \cdot \gamma \cdot R$$



with  $\gamma$ : Surface tension  
 $R$ : Particle radius

# Particle adhesion – Dependence on particle size



## Particle removal by an air flow

Particle removal by an air flow is due to **drag** and **buoyant forces**. Both forces are derived from the Bernoulli equation

$$p(x, y, z) + \frac{1}{2} \cdot \rho_a \cdot u(x, y, z)^2 = p_0 = \text{const}$$

with  $\rho_a$ : density of air  
 $u(x, y, z)$ : velocity of the air flow at point (x,y,z)  
 $p_0$ : ambient pressure ( $u = 0$ )

The dynamic pressure of the air flow is then given by  $p_d = \frac{1}{2} \cdot \rho_a \cdot u^2 = p_0 - p$

while the static pressure of the air flow is given by  $p_s = p = p_0 - p_d$

## Particle removal by an air flow – I. Drag forces

The total drag force is calculated by integrating the dynamic pressure over the 'in stream' area of the particle (frontal area):

$$F_d = \iint_A \frac{\rho_a}{2} \cdot u(z, y)^2 \cdot dz \cdot dy$$

Problem:  $u(z, y)$  cannot be determined for real particles which may have complex shapes and rough surfaces. For arbitrarily shaped bodies, the influence of these parameters is integrally described by the drag coefficient  $c_w$ , and the drag force  $F_d$  is described by the expression

$$F_d = c_w \cdot \frac{\rho_a}{2} \cdot u_\infty^2 \cdot A$$

with  $u_\infty$  the velocity of the undisturbed air flow, and  $A$  the frontal area of the particle.



# Particle removal by an air flow – I. Buoyancy

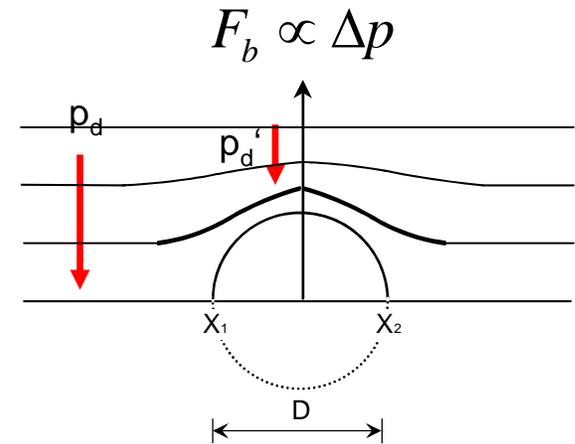
Buoyancy effects are also derived from the Bernoulli equation. A practical expression is

$$F_b = c_b \cdot \frac{\rho_a}{2} \cdot u_\infty^2 \cdot A$$

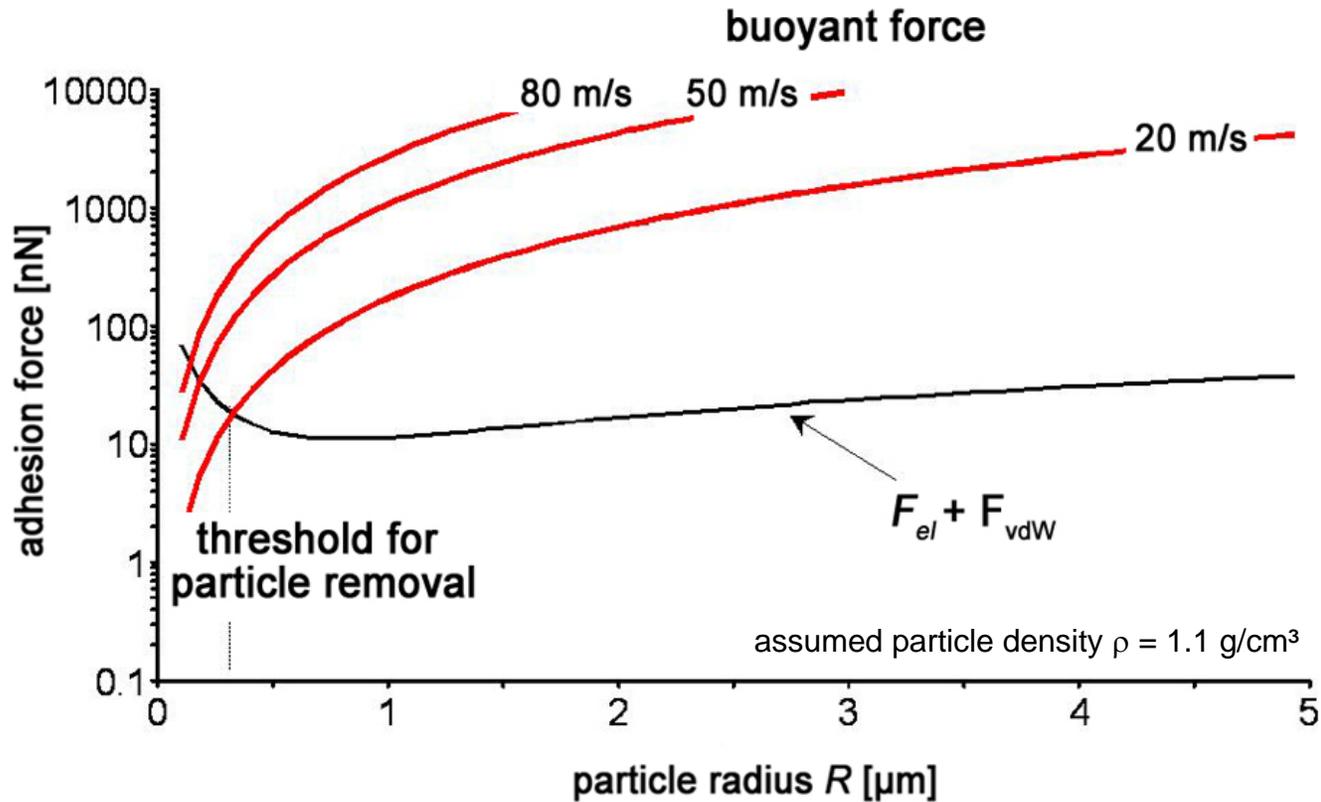
with  $u_\infty$  the velocity of the undisturbed air flow, and  $A$  the frontal area of the particle.

In this expression,  $c_b$  is the buoyancy coefficient.

For spherical particles on a plane,  $c_b$  can be assumed to  $c_b \approx 0.25$ .



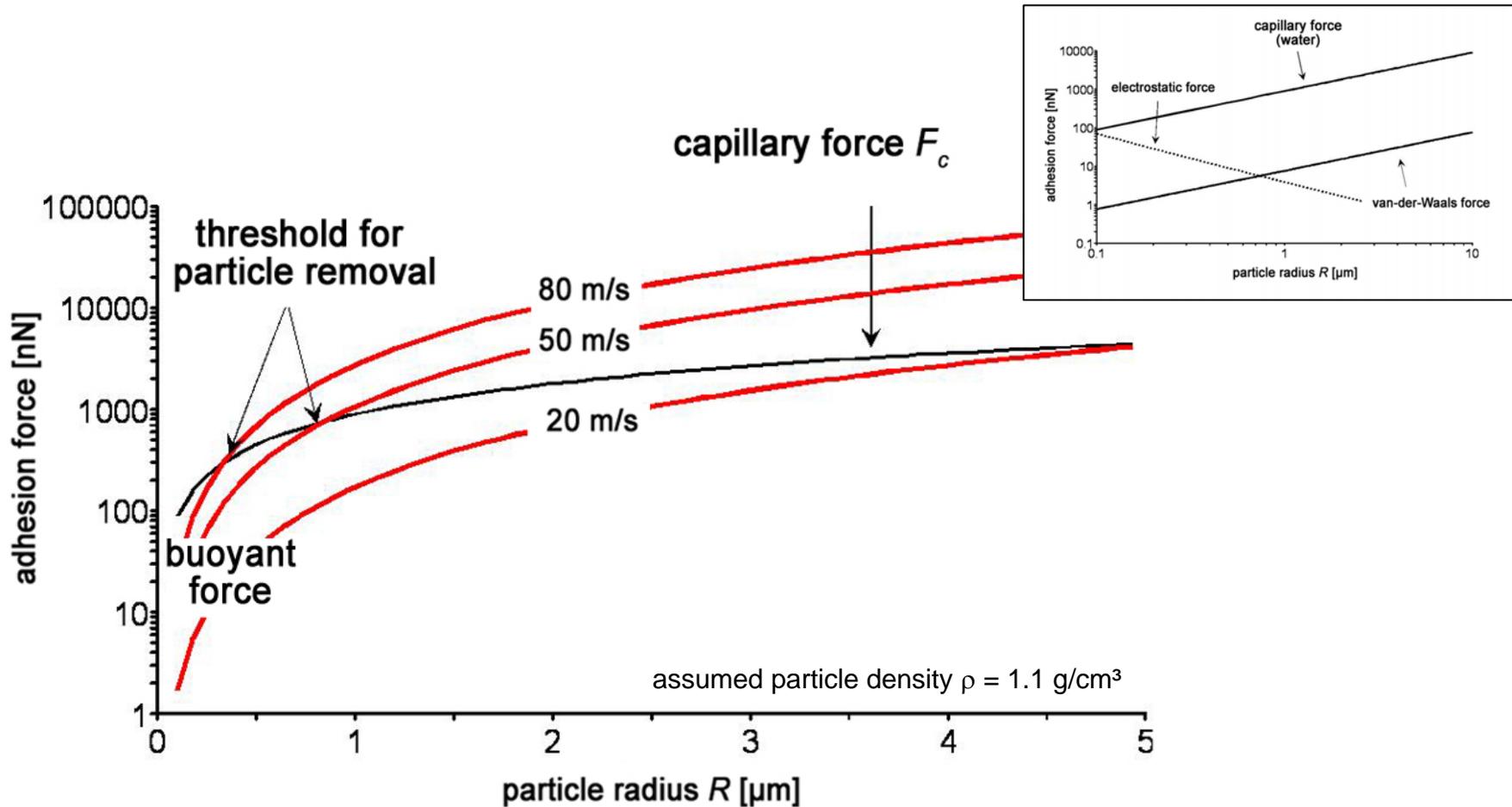
# Particle removal by an air flow – Case 1: Only $F_{el}$ and $F_{vdw}$



⇒ Air flows of rather low velocities can be expected remove even submicron particles efficiently



# Particle removal by an air flow – Case 2: (Additional) capillary forces



⇒ High speed air flows are required, if capillary forces act.



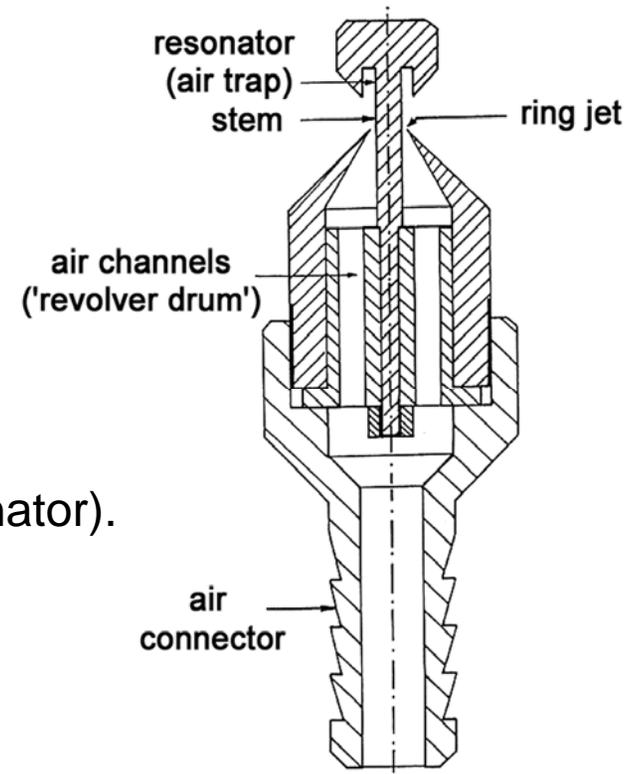
# Oscillating high-speed air flows and ultrasound

Oscillating air flow removal systems are occasionally found in (textile) industry for the cleaning of, e.g., delicate technical fabrics. But frequencies and air velocities are low.

As a potential source for **high-speed oscillating air flows**, a hydrodynamic device designed as a 'pneumatic flip-flop' was considered.

Working cycle:

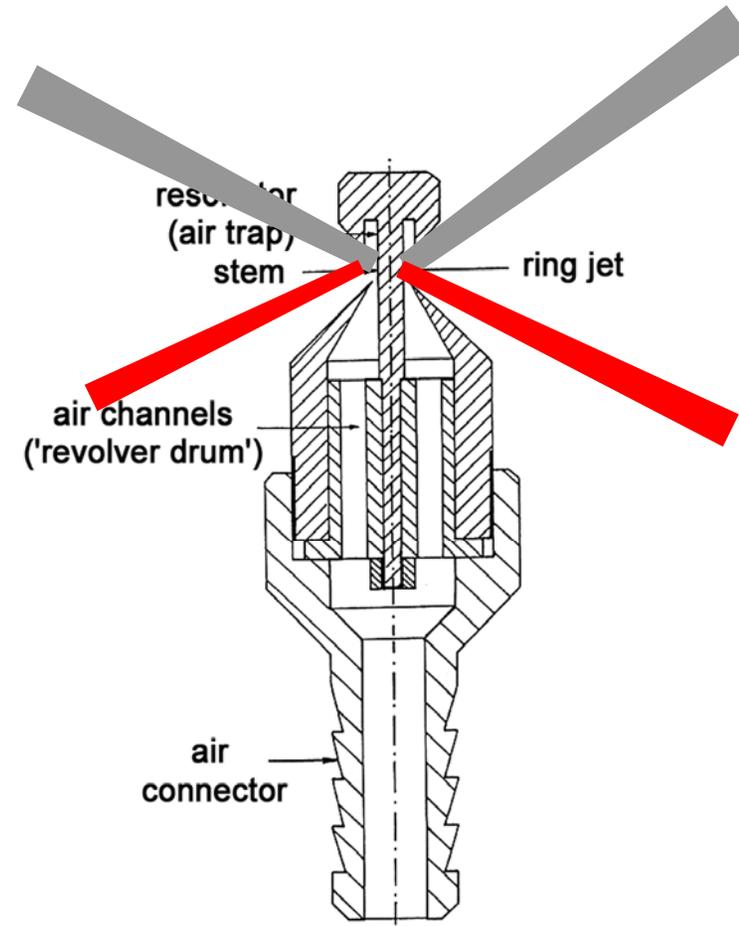
1. Pressurized air is guided into a flow trap (resonator).
2. Pressure in the flow trap increases and
3. the air flow is diverted out of the air gap.
4. Pressure in the flow decreases and
5. cycle resumes.



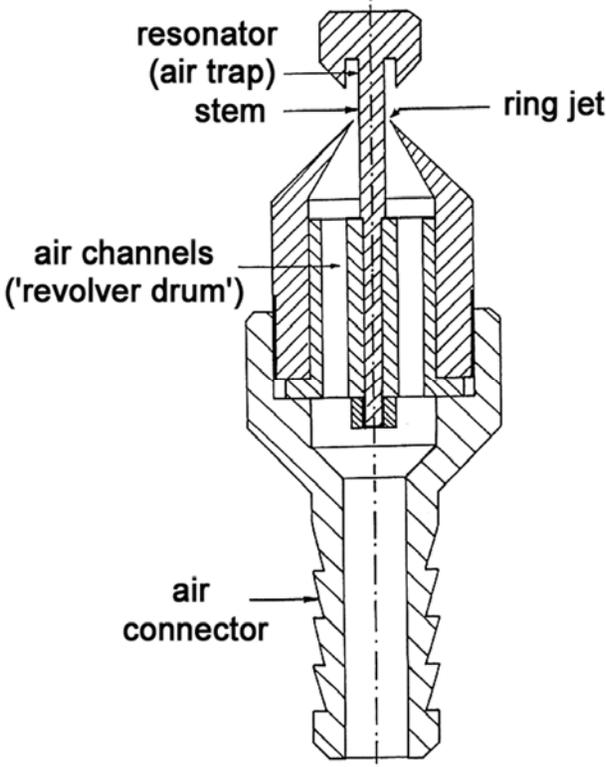
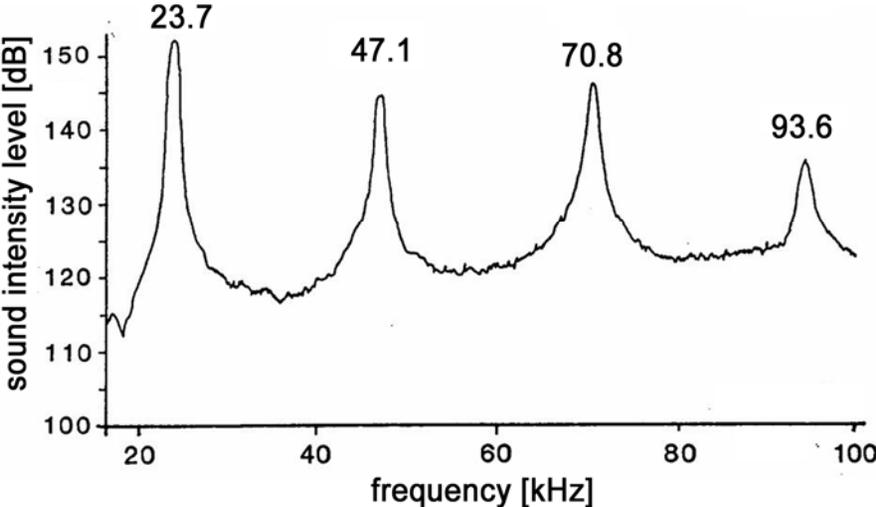
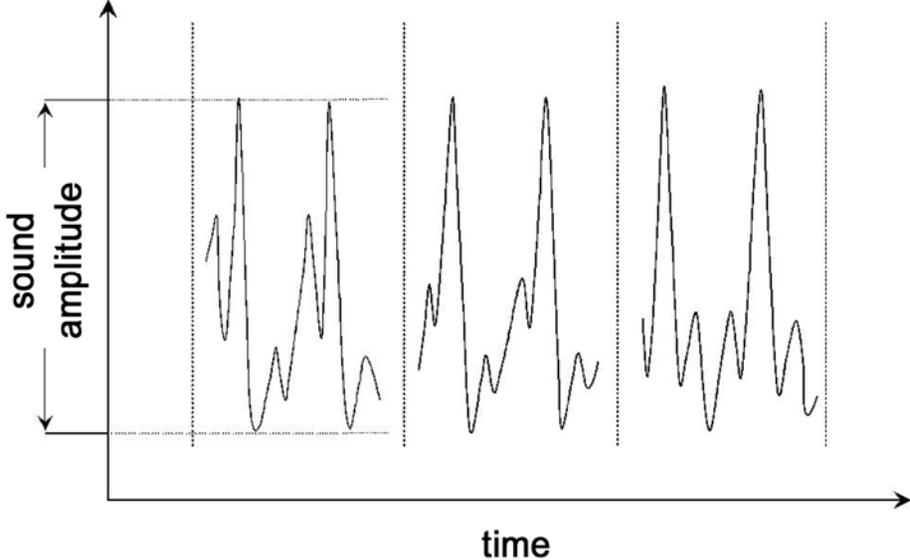
# Oscillating high-speed air flows and ultrasound

Due to the collapse of the forward facing air flow, an ultrasonic wave in backward direction is generated!

**Can we use the ultrasonic wave/field for particle removal similar to ultrasonic cleaning in 'baths'?**



# Characteristics of the generated ultrasound wave



## Forces effected by ultrasonic waves

If one assumes a harmonic signal, the force on a particle is given by

$$F_{US} = m \cdot a = m \cdot \omega \cdot v = m \cdot (2\pi \cdot f) \cdot v$$

where  $m$  is the mass of the particle,  $f$  the frequency of the ultrasonic wave and  $v$  the sound velocity. The sound velocity is derived from

(a) the sound intensity level  $L = 20 \cdot \log\left(\frac{p}{p_0}\right)$

and (b) the acoustic impedance  $Z_0 = \frac{p}{V} = \rho_a \cdot c$

$p$ : pressure of the sound wave

$p_0$ : hearing threshold at 1 kHz;  $p_0 = 2 \cdot 10^{-5} \text{ N/m}^2$

$\rho_a, c$ : density of air and speed of sound in air  $\Rightarrow Z_0 = 408 \text{ N}\cdot\text{s/m}^3$



## Forces effected by ultrasonic waves

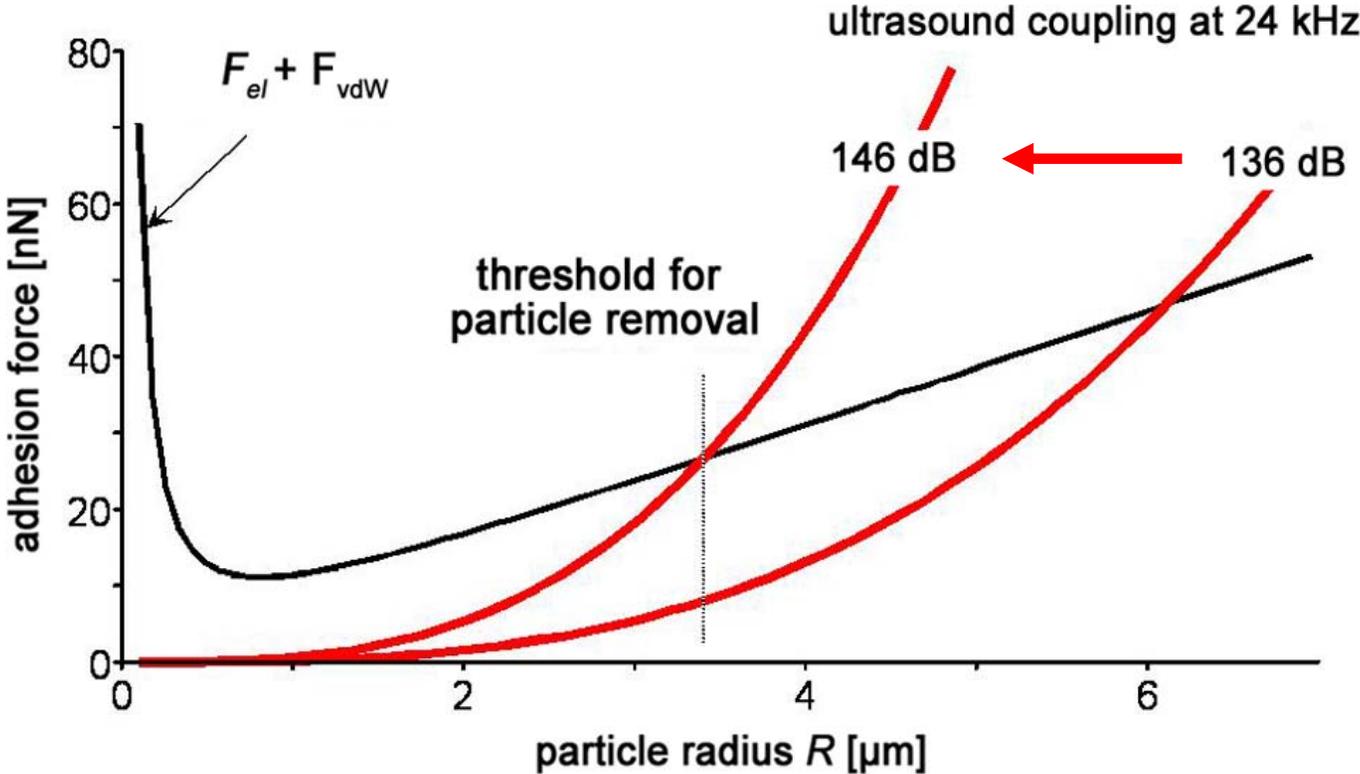
With the given values of  $\rho$ ,  $c$ ,  $\rho_0$  and experimentally determined values of the sound pressure  $p$  at the harmonics, one obtains:

- sound velocity  $v = 0.296$  m/s
- effective acceleration at 24 kHz (136 dB)  $a \approx 45,000$  m/s<sup>2</sup>
- effective acceleration at 94 kHz  $a \approx 175,000$  m/s<sup>2</sup>

Assuming spherical particles and a particle density of 1.1 g/cm<sup>3</sup>, the resulting force  $F_{US}$  can be estimated and again compared to determining adhesion forces.



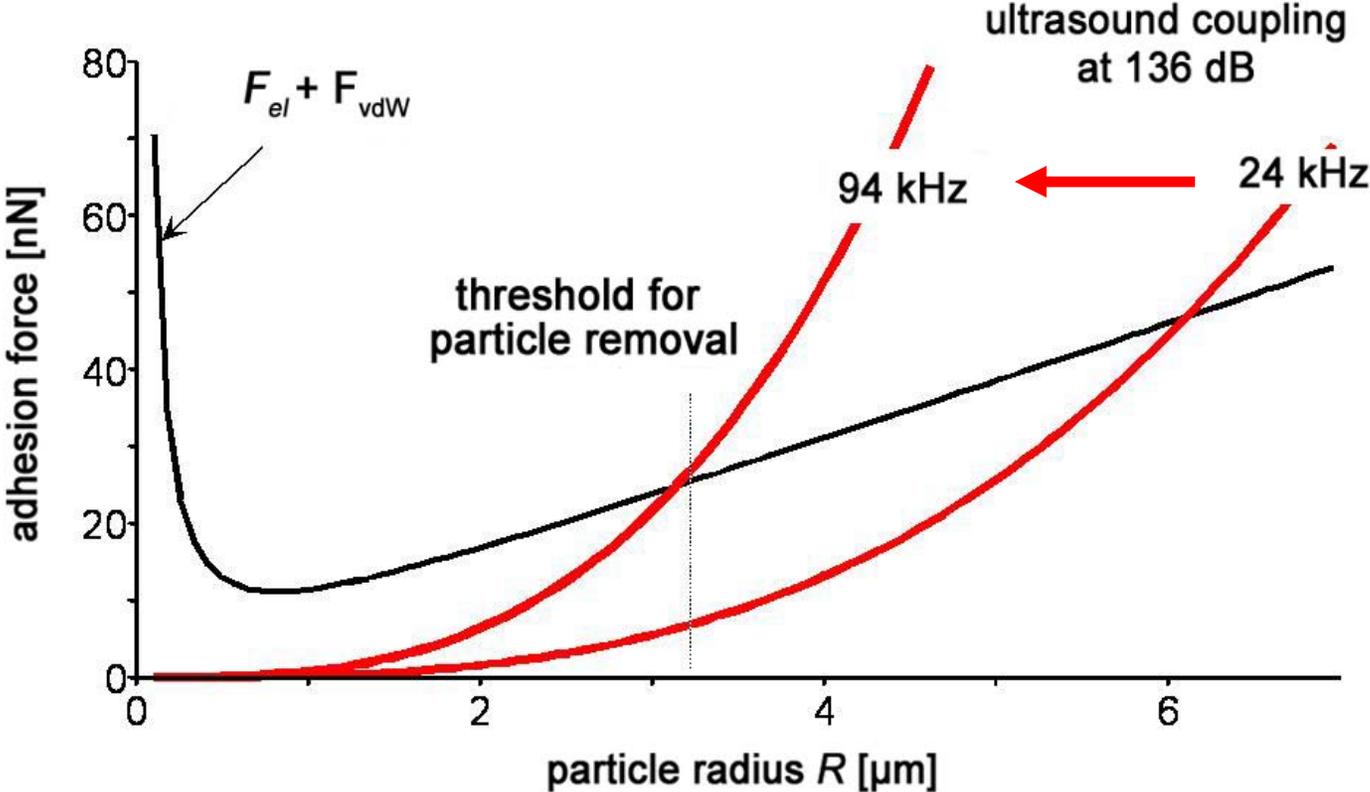
# Particle removal by ultrasound – Case 1: Only $F_{el}$ and $F_{vdW}$



Increase of sound pressure moves the threshold for particle removal to smaller particles, but the threshold is still way above 1  $\mu\text{m}$



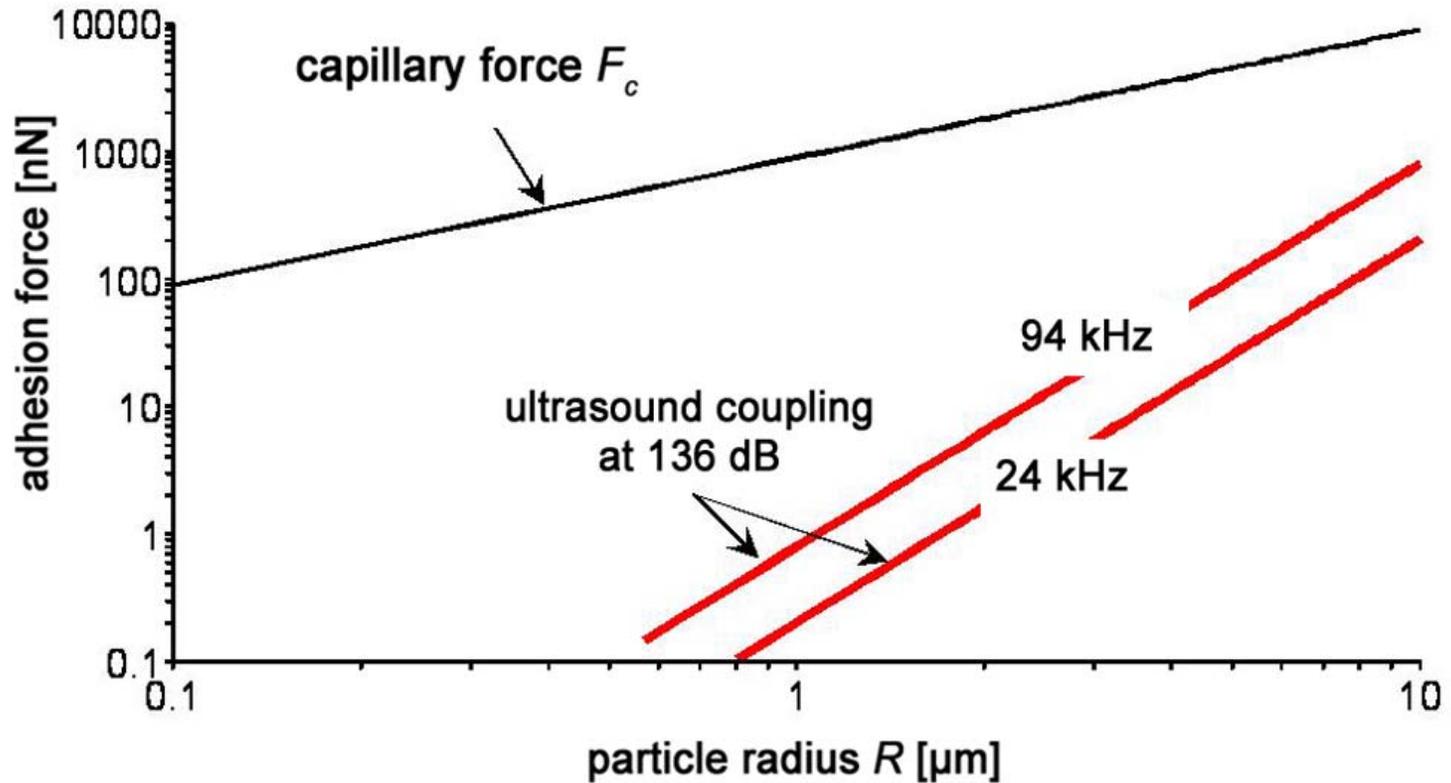
# Particle removal by ultrasound – Case 1: Only $F_{el}$ and $F_{vdW}$



The threshold for particle removal can be shifted to smaller particles also by using high US frequencies.



# Particle removal by ultrasound – Case 2: (Additional) capillary forces



Ultrasound alone does not suffice to overcome capillary adhesion forces of particles in the micron and submicron size range



# Thank you for your attention!

## The authors wish to acknowledge

financial support by the *Forschungskuratorium Textil e.V.* for part of the study in the framework of project AiF-Nr. 10193 N

(This support granted within the program *Industrielle Gemeinschaftsforschung (IGF)* from resources of the *Bundesministerium für Wirtschaft und Technologie (BMWi)* via a supplementary contribution by the *Arbeitsgemeinschaft Industrieller Forschungsvereinigungen e.V. (AiF)*)

